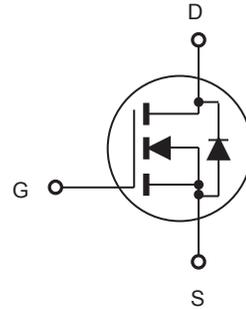


## N-Channel Enhancement Mode Field Effect Transistor

### FEATURES

Type	V <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>	@V <sub>GS</sub>
CEP9060N	55V	10.5mΩ	90A	10V
CEB9060N	55V	10.5mΩ	90A	10V
CEF9060N	55V	10.5mΩ	90A <sup>e</sup>	10V

- Super high dense cell design for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability.
- Lead free product is acquired.
- TO-220 & TO-263 package & TO-220F full-pak for through hole.



### ABSOLUTE MAXIMUM RATINGS $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Limit		Units
		TO-220/263	TO-220F	
Drain-Source Voltage	V <sub>DS</sub>	55		V
Gate-Source Voltage	V <sub>GS</sub>	±20		V
Drain Current-Continuous	I <sub>D</sub>	90	90 <sup>e</sup>	A
Drain Current-Pulsed <sup>a</sup>	I <sub>DM</sub> <sup>f</sup>	360	360 <sup>e</sup>	A
Maximum Power Dissipation @ T <sub>C</sub> = 25°C - Derate above 25°C	P <sub>D</sub>	166	49	W
		1.11	0.33	W/°C
Single Pulsed Avalanche Energy <sup>d</sup>	E <sub>AS</sub>	325	325	mJ
Single Pulsed Avalanche Current <sup>d</sup>	I <sub>AS</sub>	50	50	A
Operating and Store Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175		°C

### Thermal Characteristics

Parameter	Symbol	Limit		Units
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	0.9	3	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	62.5	65	°C/W



# CEP9060N/CEB9060N CEF9060N

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## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	55			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 55V, V_{GS} = 0V$			25	$\mu A$
Gate Body Leakage Current, Forward	$I_{GSSF}$	$V_{GS} = 20V, V_{DS} = 0V$			100	nA
Gate Body Leakage Current, Reverse	$I_{GSSR}$	$V_{GS} = -20V, V_{DS} = 0V$			-100	nA
<b>On Characteristics<sup>b</sup></b>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	2		4	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 62A$		8.5	10.5	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 25V, I_D = 62A$		30		S
<b>Dynamic Characteristics<sup>c</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 25V, V_{GS} = 0V, f = 1.0\text{ MHz}$		3695		pF
Output Capacitance	$C_{oss}$			765		pF
Reverse Transfer Capacitance	$C_{rss}$			60		pF
<b>Switching Characteristics<sup>c</sup></b>						
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 28V, I_D = 62A, V_{GS} = 10V, R_{GEN} = 4.5\Omega$		24	48	ns
Turn-On Rise Time	$t_r$			11.9	23.8	ns
Turn-Off Delay Time	$t_{d(off)}$			60	120	ns
Turn-Off Fall Time	$t_f$			19	38□	ns
Total Gate Charge	$Q_g$	$V_{DS} = 44V, I_D = 62A, V_{GS} = 10V$		68.1	90.5	nC
Gate-Source Charge	$Q_{gs}$			12.6		nC
Gate-Drain Charge	$Q_{gd}$			22.7		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Drain-Source Diode Forward Current	$I_S$				62	A
Drain-Source Diode Forward Voltage <sup>b</sup>	$V_{SD}$	$V_{GS} = 0V, I_S = 62A$			1.3	V
<b>Notes :</b> □ a.Repetitive Rating : Pulse width limited by maximum junction temperature b.Pulse Test : Pulse Width $\leq 300\mu s$ , Duty Cycle $\leq 2\%$ . □ c.Guaranteed by design, not subject to production testing. □ d.L = 260 $\mu H$ , $I_{AS} = 50A$ , $V_{DD} = 24V$ , $R_G = 25\Omega$ , Starting $T_J = 25^\circ C$ e.Limited only by maximum temperature allowed . f.Pulse width limited by safe operating area .						



# CEP9060N/CEB9060N CEF9060N

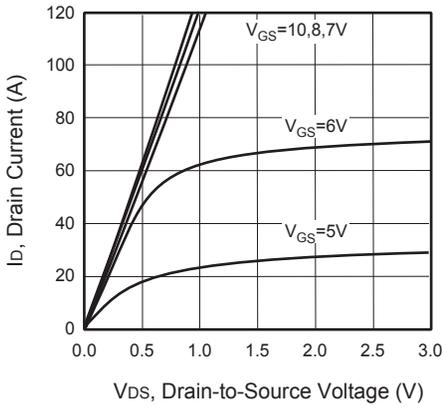


Figure 1. Output Characteristics

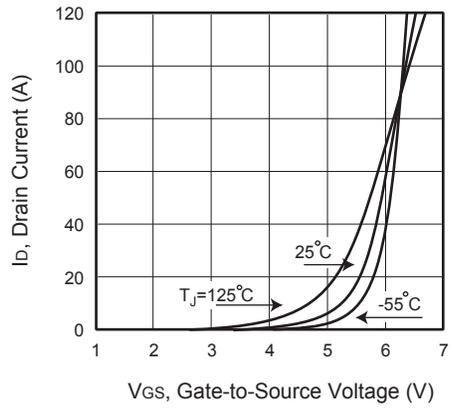


Figure 2. Transfer Characteristics

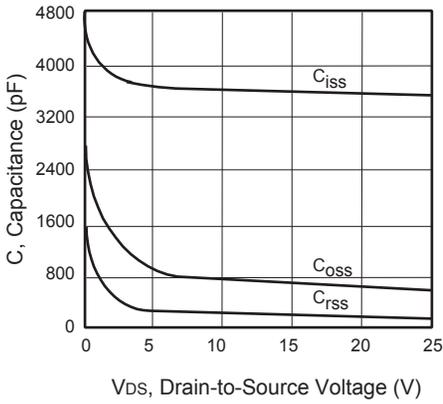


Figure 3. Capacitance

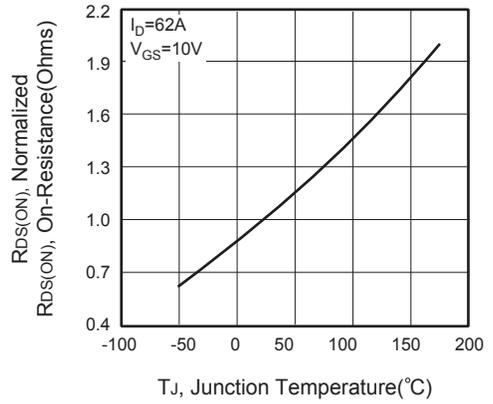


Figure 4. On-Resistance Variation with Temperature

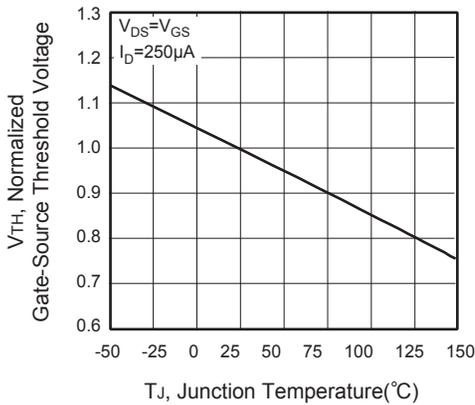


Figure 5. Gate Threshold Variation with Temperature

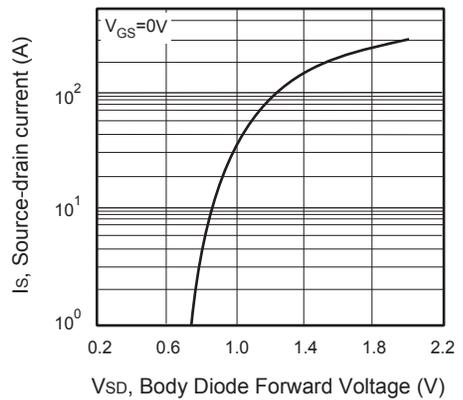


Figure 6. Body Diode Forward Voltage Variation with Source Current

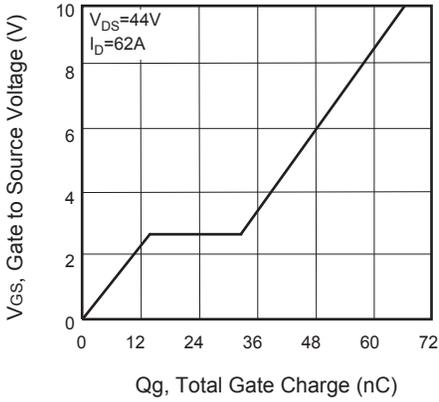


Figure 7. Gate Charge

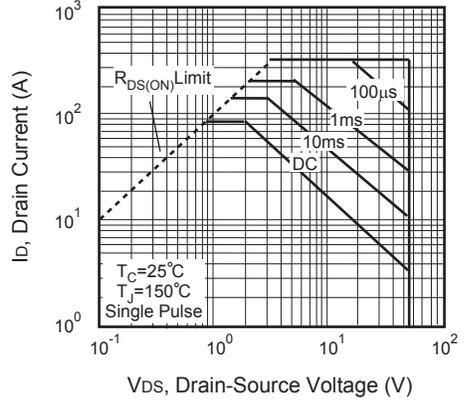


Figure 8. Maximum Safe Operating Area

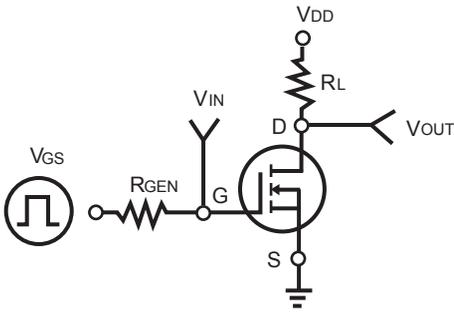


Figure 9. Switching Test Circuit

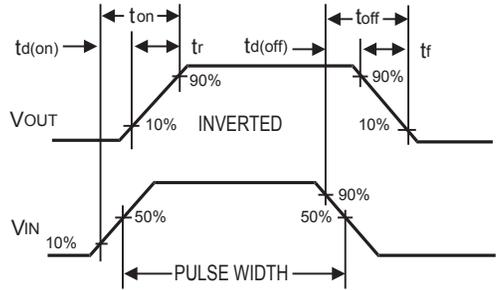


Figure 10. Switching Waveforms

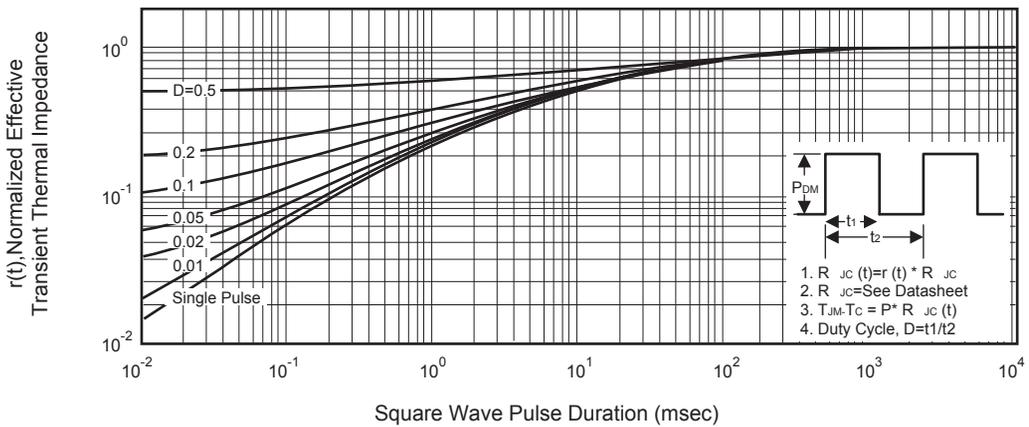


Figure 11. Normalized Thermal Transient Impedance Curve